

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/789,905	CHUNG, YI-SUN	
Examiner		Art Unit		Page 1 of 1
Anh D. Mai		2814		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,100,770 A	08-2000	Litwin et al.	331/117FE
	B	US-6,518,634 B1	02-2003	Kaushik et al.	257/406
	C	US-6,653,716 B1	11-2003	Vashchenko et al.	257/596
	D	US-6,717,226 B2	04-2004	Hegde et al.	257/406
	E	US-2002/0074589 A1	06-2002	Benaissa et al.	257/312
	F	US-2003/0102498 A1	06-2003	Braithwaite et al.	257/288
	G	US-2003/0232506 A1	12-2003	Metzner et al.	438/761
	H	US-2004/0180487 A1	09-2004	Eppich et al.	438/199
	I	US-6,087,236 A	07-2000	Chau et al.	438/301
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.